Notice for TAIYO YUDEN products

Please read this notice before using the TAIYO YUDEN products.

REMINDERS

Product information in this catalog is as of October 2016. All of the contents specified herein are subject to change without notice due to technical improvements, etc. Therefore, please check for the latest information carefully before practical application or use of our products.

Please note that TAIYO YUDEN shall not be in any way responsible for any damages and defects in products or equipment incorporating our products, which are caused under the conditions other than those specified in this catalog or individual specification.

- Please contact TAIYO YUDEN for further details of product specifications as the individual specification is available.
- Please conduct validation and verification of our products in actual condition of mounting and operating environment before using our products.
- The products listed in this catalog are intended for use in general electronic equipment (e.g., AV equipment, OA equipment, home electric appliances, office equipment, information and communication equipment including, without limitation, mobile phone, and PC). Please be sure to contact TAIYO YUDEN for further information before using the products for any equipment which may directly cause loss of human life or bodily injury (e.g., transportation equipment including, without limitation, automotive powertrain control system, train control system, and ship control system, traffic signal equipment, disaster prevention equipment, medical equipment, highly public information network equipment including, without limitation, telephone exchange, and base station).

Please do not incorporate our products into any equipment requiring high levels of safety and/or reliability (e.g., aerospace equipment, aviation equipment, nuclear control equipment, undersea equipment, military equipment).

When our products are used even for high safety and/or reliability-required devices or circuits of general electronic equipment, it is strongly recommended to perform a thorough safety evaluation prior to use of our products and to install a protection circuit as necessary.

Please note that unless you obtain prior written consent of TAIYO YUDEN, TAIYO YUDEN shall not be in any way responsible for any damages incurred by you or third parties arising from use of the products listed in this catalog for any equipment requiring inquiry to TAIYO YUDEN or prohibited for use by TAIYO YUDEN as described above.

- Please note that TAIYO YUDEN shall have no responsibility for any controversies or disputes that may occur in connection with a third party's intellectual property rights and other related rights arising from use of our products. TAIYO YUDEN grants no license for such rights.
- Please note that unless otherwise agreed in writing, the scope of warranty for our products is limited to the delivered our products themselves and TAIYO YUDEN shall not be in any way responsible for any damages resulting from a fault or defect in our products.
- The contents of this catalog are applicable to our products which are purchased from our sales offices or authorized distributors (hereinafter "TAIYO YUDEN's official sales channel"). Please note that the contents of this catalog are not applicable to our products purchased from any seller other than TAIYO YUDEN's official sales channel.
- Caution for Export

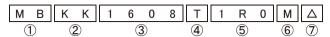
Some of our products listed in this catalog may require specific procedures for export according to "U.S. Export Administration Regulations", "Foreign Exchange and Foreign Trade Control Law" of Japan, and other applicable regulations. Should you have any questions on this matter, please contact our sales staff.

METAL WIRE-WOUND CHIP POWER INDUCTORS(MCOILTM MB SERIES)



PARTS NUMBER

* Operating Temp.:- $40\sim+105^{\circ}C$ (Including self-generated heat)



△=Blank space

①Series name

Code	Series name
MB	Metal Wire-Wound chip power inductor

⑤Nominal inductance

eries riairie		- I ackaging	
Code	Series name	Code	Packaging
MB	Metal Wire-Wound chip power inductor	Т	Taping

②Dimensions (T)					
Code	Dimensions (T) [mm]				
KK	1.0				
MK	1.2				

	-	
	Code (example)	Nominal inductance [μ H]
	R24	0.24
	1R0	1.0
4R7		4.7

③Dimensions (L × W)

Code	Type(inch)	Dimensions (L×W)[mm]
1608	1608 (0603)	1.6 × 0.8
2012	2012 (0805)	2.0 × 1.25
2520	2520 (1008)	2.5 × 2.0

6 Inductance tolerance

Code	Inductance tolerance
М	±20%
N	±30%

7Internal code

■ STANDARD EXTERNAL DIMENSIONS / STANDARD QUANTITY

Recommended Land Patterns

•Mounting and soldering conditions should be checked beforehand.

*Applicable soldering process to these products is reflow soldering only.



Type	Α	В	С
1608	0.55	0.70	1.00
2012	0.60	1.00	1.45
2520	0.60	1.50	2.00

Unit:mm

Tyma		W	_		Standard quantity[pcs]		
Туре	L	VV	_	е	Paper tape	Embossed tape	
MBKK1608	1.6±0.2	0.8 ± 0.2	1.0 max	0.45±0.15		3000	
MBKK1008	(0.063 ± 0.008)	(0.031 ± 0.008)	(0.040 max)	(0.016±0.006)		3000	
MPKK2012	2.0±0.2	1.25±0.2	1.0 max	0.5±0.2	_	3000	
MBKK2012	(0.079 ± 0.008)	(0.049 ± 0.008)	(0.040 max)	(0.020 ± 0.008)	_	3000	
MBMK2520	2.5±0.2	2.0±0.2	1.2 max	0.5±0.2		3000	
MIDIMINZOZU	(0.098 ± 0.008)	(0.079 ± 0.008)	(0.047 max)	(0.020 ± 0.008)	_	3000	
						Unit:mm(inch)	

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	EHS	Nominal inductance [μ H]	Inductance tolerance	Self-resonant	DC Resistance [Ω] (max.)	Rated curre		
Parts number				frequency [MHz] (min.)		Saturation current Idc1	Temperature rise current Idc2	Measuring frequency[MHz]
MBKK1608TR24N	RoHS	0.24	±30%	-	0.049	1,650	2,300	1.0
MBKK1608TR47N	RoHS	0.47	±30%	-	0.104	1,100	1,400	1.0
MBKK1608TR68N	RoHS	0.68	±30%	-	0.120	950	1,200	1.0
MBKK1608T1R0M	RoHS	1.0	±20%	-	0.150	800	1,150	1.0
MBKK1608T1R5M	RoHS	1.5	±20%	-	0.200	650	1,000	1.0
MBKK1608T2R2M	RoHS	2.2	±20%	-	0.345	520	750	1.0
MBKK1608T3R3M	RoHS	3.3	±20%	-	0.512	450	600	1.0
MBKK1608T4R7M	RoHS	4.7	±20%	-	0.730	370	500	1.0

	EHS	Nominal inductance [μ H]	Inductance tolerance	Self-resonant	DC Resistance [Ω] (max.)	Rated current ※)[mA]		Measuring
Parts number				frequency [MHz] (min.)		Saturation current Idc1	Temperature rise current Idc2	frequency[MHz]
MBKK2012TR24N	RoHS	0.24	±30%	-	0.041	3,000	2,400	1.0
MBKK2012TR47N	RoHS	0.47	±30%	-	0.078	2,000	1,650	1.0
MBKK2012TR68N	RoHS	0.68	±30%	-	0.090	1,800	1,500	1.0
MBKK2012T1R0M	RoHS	1.0	±20%	ı	0.106	1,500	1,450	1.0
MBKK2012T1R5M	RoHS	1.5	±20%	ı	0.173	1,200	1,100	1.0
MBKK2012T2R2M	RoHS	2.2	±20%	ı	0.290	900	850	1.0
MBKK2012T3R3M	RoHS	3.3	±20%	1	0.500	700	650	1.0
MBKK2012T4R7M	RoHS	4.7	±20%	-	0.615	600	600	1.0

MBMK2520(1008) type Thickness: 1.2mm max.

- IIIDIIII (LOLO (1000) typo		Timorarocc. I.Emin						
	arts number EHS	Nominal inductance [μ H]	Inductance tolerance	Self-resonant	DC Resistance [Ω](max.)	Rated current ※)[mA]		Measuring
Parts number				frequency [MHz] (min.)		Saturation current Idc1	Temperature rise current Idc2	frequency[MHz]
MBMK2520TR24N	RoHS	0.24	±30%	ı	0.026	4,750	3,500	1.0
MBMK2520TR47N	RoHS	0.47	±30%	1	0.042	3,900	2,600	1.0
MBMK2520TR68N	RoHS	0.68	±30%	-	0.058	3,150	2,150	1.0
MBMK2520T1R0M	RoHS	1.0	±20%	-	0.072	2,350	1,850	1.0
MBMK2520T1R5M	RoHS	1.5	±20%	-	0.106	2,050	1,500	1.0
MBMK2520T2R2M	RoHS	2.2	±20%	-	0.159	1,800	1,250	1.0
MBMK2520T3R3M	R ₀ HS	3.3	±20%	-	0.260	1,400	970	1.0
MBMK2520T4R7M	R ₀ HS	4.7	±20%	-	0.380	1,150	800	1.0

- $\frak{\%}$) The saturation current value (Idc1) is the DC current value having inductance decrease down to 30%. (at 20°C)
- $\frak{\%}$) The temperature rise current value (Idc2) is the DC current value having temperature increase by 40°C. (at 20°C)
- $\ensuremath{\mbox{\%}}\xspace) The rated current value is following either Idc1 or Idc2, which is the lower one.$

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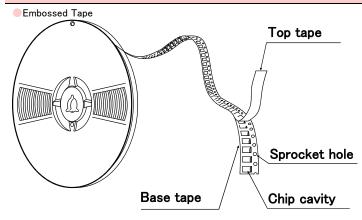
METAL WIRE-WOUND CHIP POWER INDUCTORS (MCOIL™ MB SERIES)

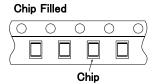
PACKAGING

1 Minimum Quantity

Туре	Standard Quantity [pcs]
	Tape & Reel
MBKK1608	3000
MBKK2012	3000
MBMK2520	3000

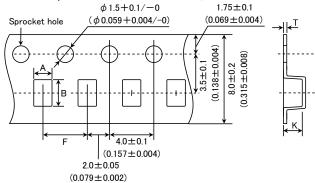
2Tape Material

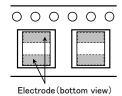




3Taping dimensions

Embossed tape 8mm wide (0.315 inches wide) ϕ 1.5+0.1/-0

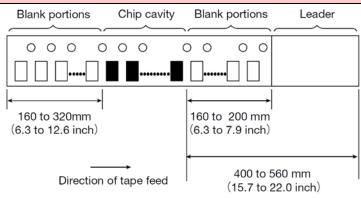




Tuma	Chip	cavity	Insertion pitch	Tape thickness		
Туре	Α	В	F	T	K	
MDVV1600	1.1	1.9	4.0±0.1	0.25 ± 0.05	1.2 max	
MBKK1608	(0.043)	(0.075)	(0.157 ± 0.004)	(0.010 ± 0.002)	(0.047 max)	
MBKK2012	1.45	2.2	4.0±0.1	0.25±0.05	1.2 max	
WIDKKZUIZ	(0.057)	(0.087)	(0.157 ± 0.004)	(0.010 ± 0.002)	(0.047 max)	
MBMK2520	2.3	2.8	4.0±0.1	0.3 ± 0.05	1.45 max	
INDINIVA	(0.091)	(0.110)	(0.157 ± 0.004)	(0.012 ± 0.002)	(0.057 max)	

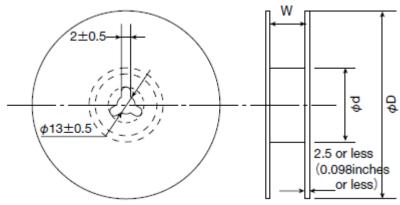
Unit:mm(inch)

4 Leader and Blank portion



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⑤Reel size

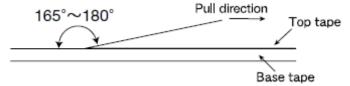


Type	Reel size (Reference values)				
Type	ϕ D	ϕ d	W		
MBKK1608	180+0/-3	60+1/-0	10.0±1.5		
MBKK2012	(7.087+0/-0.118)	(2.36+0.039/0)	(0.394 ± 0.059)		
MBMK2520					

Unit:mm(inch)

6Top Tape Strength

The top The top tape requires a peel-off force of 0.2 to 0.7N in the direction of the arrow as illustrated below.



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METAL WIRE-WOUND CHIP POWER INDUCTORS (MCOIL™ MB SERIES)

■RELIABILITY DATA

1. Operating Tempe	rature Range	
Specified Value	MB series	-40~+105°C
Test Methods and Remarks	Including self-generated heat	
2. Storage Tempera	ture Range	
Specified Value	MB series	-40~+85°C
Test Methods and Remarks	0 to 40°C for the product with taping.	
3. Rated current		
Specified Value	MB series	Within the specified tolerance
Specified Value	IND Selies	Mullin the Specified tolerance
4. Inductance		
Specified Value	MB series	Within the specified tolerance
Test Methods and Remarks	Measuring equipment : LCR Meter (HP 4 Measuring frequency : 1MHz, 1V	
F DO Design		
5. DC Resistance	MB series	With the second section of the section of the second section of the section of the second section of the second section of the se
Specified Value Test Methods and	MB series	Within the specified tolerance
Remarks	Measuring equipment : DC ohmmeter (HI	OKI 3227 or equivalent)
6. Self resonance fr	requency	
Specified Value	MB series	_
7. Temperature cha	racteristic	
Specified Value	MB series	Inductance change : Within ±15%
Test Methods and Remarks	Measurement of inductance shall be taken at With reference to inductance value at +20°C	temperature range within $-40^{\circ}\text{C} \sim +105^{\circ}\text{C}$.
8. Resistance to fle		
Specified Value	MB series	No damage
Test Methods and Remarks	until deflection of the test board reaches to	mm (1608:0.8mm) Force Rod 10 20
9. Insulation resista	nce : between wires	
Specified Value	MB series	-
10. Insulation resist	ance : between wire and core	
Specified Value	MB series	DC25V 100kΩ min
11. Withstanding vo	Itage : between wire and core	
	ruge i becireen in e una eere	
Specified Value	MB series	-

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12. Adhesion of terr	ninal electrode				
Specified Value	MB series		No abnormality.		
Test Methods and Remarks	The test samples shall be s Applied force Duration Solder cream thickness		est board by the reflow. N) to X and Y directions.		
13. Resistance to vi	bration				
Specified Value	MB series		Inductance change : No significant abnorm		
	The test samples shall be s	oldered to the te	est board by the reflow.		
	Then it shall be submitted	o below test cor	nditions.		_
	Frequency Range	10∼55Hz			
Test Methods and	Total Amplitude	1.5mm (May no	ot exceed acceleration 19	96m/s²)	
Remarks	Sweeping Method	10Hz to 55Hz t	to 10Hz for 1min.		
Remarks	Time	X Y Z	For 2 hours on each	X, Y, and Z axis.	
	Recovery : At least 2hrs of	recovery under	the standard condition a	fter the test, followed by	ப the measurement within 48hrs.
	<u> </u>				
14. Solderability					
Specified Value	MB series		At least 00% of our	ace of terminal electrode	is accord by now colder
Specified value			1		
	The test samples shall be o	* *		n solder as shown in belo	w table.
T . M .: .	Flux : Methanol solution co		70.		
Test Methods and	Solder Temperature	245±5°C			
Remarks	Immersing speed	25mm/s			
	Time	5±0.5 sec.			
	※Immersion depth : All sid	es of mounting to	erminal shall be immerse	<u>a.</u>	
15. Resistance to se	oldering heat				
Specified Value	MB series		Inductance change : No significant abnorm		
Test Methods and Remarks	Test board material : Test board thickness :	Glass epoxy-resi 1.0mm	n		re at $260+0/-5^{\circ}$ C for 5 seconds, 3 time the measurement within 48hrs.
16. Thermal shock					
Specified Value	MB series		Inductance change : No significant abnorm		
	The test samples shall be s	oldered to the te	st board by the reflow. T	he test samples shall be p	laced at specified temperature for specific
	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed at specified temperature for specified time by step 1 to step 4 as shown in below table in sequence. The temperature cycle shall be repeated 100 cycles.				
	•	shown in below	table in sequence. The t	emperature cycle shall be	repeated 100 cycles.
	time by step 1 to step 4 as	shown in below		emperature cycle shall be 	repeated 100 cycles.
Test Methods and	time by step 1 to step 4 as	ditions of 1 cycl		emperature cycle shall be	repeated 100 cycles.

Tot Titotitial offort				
Specified Value	MB series		Inductance change : No significant abnor	Within ±10% mality in appearance.
		•	elow table in sequence. The	The test samples shall be placed at specified temperature for specified temperature cycle shall be repeated 100 cycles.
Test Methods and	Step	Temperature (°C)	Duration (min)	
Remarks	1	-40 ± 3	30±3	
Remarks	2	Room temperature	Within 3	
	3	+85±2	30±3	
	4	Room temperature	Within 3	
	Recovery: At least 2hrs of recovery under the standard condition after the test, followed by the measurement within 48hrs.			

17. Damp heat				
Specified Value	MB series		Inductance change : Within ±10% No significant abnormality in appearance.	
T . M .:	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified		st board by the reflow. atic oven set at specified temperature and humidity as shown in below table.	
Test Methods and	Temperature	60±2°C		
Remarks	Humidity	90∼95%RH		
	Time	1000+24/-0 hour		
	Recovery: At least 2hrs of recovery under the standard condition after the test, followed by the measurement within 48hrs.			

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18. Loading under d	lamp heat		
Specified Value MB series			Inductance change : Within ±10%
Specified value	MB series		No significant abnormality in appearance.
	The test samples sh	all be soldered to the te	st board by the reflow.
	The test samples	shall be placed in therr	nostatic oven set at specified temperature and humidity and applied the rated current
Test Methods and	continuously as sho		
Remarks	Temperature	60±2°C	
	Humidity	90~95%RH	
	Applied current	Rated current	
	Time	1000+24/-0 hour	
	Recovery : At least	2hrs of recovery under t	he standard condition after the test, followed by the measurement within 48hrs.
19. Low temperatur	e life test		
0 15 11/1			Inductance change : Within ±10%
Specified Value	MB series		No significant abnormality in appearance.
	The test samples sh	all be soldered to the tes	t board by the reflow. After that, the test samples shall be placed at test conditions as shown
			·
Test Methods and	in below table.		
Test Methods and Remarks	Temperature	-40±2°C	
		-40±2°C 1000+24/-0 hour	
	Temperature Time	1000+24/-0 hour	he standard condition after the test, followed by the measurement within 48hrs.
	Temperature Time	1000+24/-0 hour	he standard condition after the test, followed by the measurement within 48hrs.
	Temperature Time Recovery : At least	1000+24/-0 hour	he standard condition after the test, followed by the measurement within 48hrs.
Remarks 20. High temperatur	Temperature Time Recovery : At least	1000+24/-0 hour	he standard condition after the test, followed by the measurement within 48hrs. Inductance change: Within ±10%
Remarks	Temperature Time Recovery : At least	1000+24/-0 hour	
Remarks 20. High temperatur	Temperature Time Recovery : At least re life test MB series	1000+24/-0 hour 2hrs of recovery under t	Inductance change : Within ±10% No significant abnormality in appearance.
Remarks 20. High temperatur	Temperature Time Recovery : At least re life test MB series	1000+24/-0 hour 2hrs of recovery under t	Inductance change : Within ±10% No significant abnormality in appearance.
20. High temperatur Specified Value	Temperature Time Recovery: At least re life test MB series The test samples sh	1000+24/-0 hour 2hrs of recovery under t	Inductance change : Within ±10% No significant abnormality in appearance.
20. High temperatur Specified Value Test Methods and	Temperature Time Recovery: At least re life test MB series The test samples sh in below table.	1000+24/-0 hour 2hrs of recovery under t	Inductance change : Within ±10% No significant abnormality in appearance.
20. High temperatur Specified Value Test Methods and	Temperature Time Recovery: At least Te life test MB series The test samples sh in below table. Temperature Time	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change : Within ±10% No significant abnormality in appearance.
20. High temperatur Specified Value Test Methods and	Temperature Time Recovery: At least Te life test MB series The test samples sh in below table. Temperature Time	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change: Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown
20. High temperature Specified Value Test Methods and Remarks	Temperature Time Recovery: At least Te life test MB series The test samples sh in below table. Temperature Time	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change : Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown
20. High temperature Specified Value Test Methods and Remarks	Temperature Time Recovery: At least MB series The test samples sh in below table. Temperature Time Recovery: At least	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change: Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown
20. High temperature Specified Value Test Methods and Remarks 21. Loading at high	Temperature Time Recovery: At least MB series The test samples sh in below table. Temperature Time Recovery: At least	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change : Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown
20. High temperature Specified Value Test Methods and Remarks 21. Loading at high	Temperature Time Recovery: At least MB series The test samples sh in below table. Temperature Time Recovery: At least	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change : Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown
20. High temperature Specified Value Test Methods and Remarks 21. Loading at high Specified Value	Temperature Time Recovery: At least MB series The test samples sh in below table. Temperature Time Recovery: At least	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change: Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown he standard condition after the test, followed by the measurement within 48hrs.
20. High temperature Specified Value Test Methods and Remarks 21. Loading at high Specified Value	Temperature Time Recovery: At least MB series The test samples sh in below table. Temperature Time Recovery: At least	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change: Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown he standard condition after the test, followed by the measurement within 48hrs. — Standard test condition:
20. High temperature Specified Value Test Methods and Remarks 21. Loading at high Specified Value	Temperature Time Recovery: At least MB series The test samples sh in below table. Temperature Time Recovery: At least	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change: Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown he standard condition after the test, followed by the measurement within 48hrs.
20. High temperature Specified Value Test Methods and Remarks 21. Loading at high Specified Value 22. Standard condit	Temperature Time Recovery: At least MB series The test samples sh in below table. Temperature Time Recovery: At least temperature life test MB series	$1000+24/-0$ hour 2hrs of recovery under to all be soldered to the tes $85\pm2^{\circ}\text{C}$ $1000+24/-0$ hour	Inductance change: Within ±10% No significant abnormality in appearance. It board by the reflow. After that, the test samples shall be placed at test conditions as shown he standard condition after the test, followed by the measurement within 48hrs. Standard test condition: Unless otherwise specified, temperature is 20±15°C and 65±20% of relative humidity.

METAL WIRE-WOUND CHIP POWER INDUCTORS (MCOIL™ MB SERIES)

■PRECAUTIONS

1. Circuit Design ◆ Operating environment 1. The products described in this specification are intended for use in general electronic equipment, (office supply equipment, telecommunications systems, measuring equipment, and household equipment). They are not intended for use in mission-critical equipment or systems requiring special quality and high reliability (traffic systems, safety equipment, aerospace systems, nuclear control systems and medical equipment including life-support systems,) where product failure might result in loss of life, injury or damage. For such uses, contact TAIYO YUDEN Sales Department in advance.

2. PCB Design	
Precautions	◆Land pattern design 1. Please refer to a recommended land pattern.
Technical considerations	 ◆Land pattern design Surface Mounting • Mounting and soldering conditions should be checked beforehand. • Applicable soldering process to this products is reflow soldering only.

3. Considerations	3. Considerations for automatic placement			
Precautions	◆Adjustment of mounting machine 1. Excessive impact load should not be imposed on the products when mounting onto the PC boards. 2. Mounting and soldering conditions should be checked beforehand.			
Technical considerations	◆Adjustment of mounting machine 1. When installing products, care should be taken not to apply distortion stress as it may deform the products.			

4. Soldering 1. Please contact any of our offices for a reflow soldering, and refer to the recommended condition specified. 2. The product shall be used reflow soldering only. Precautions 3. Please do not add any stress to a product until it returns in normal temperature after reflow soldering. Lead free soldering 1. When using products with lead free soldering, we request to use them after confirming adhesion, temperature of resistance to soldering heat, soldering etc sufficiently. ◆Reflow soldering 1. If products are used beyond the range of the recommended conditions, heat stresses may deform the products, and consequently degrade the reliability of the products. Recommended reflow condition (Pb free solder) 5sec max 300 Peak: 260+0/-5°C $Temperature[^{\circ}C]$ 150~180 Technical 200 considerations 100 90±30sec 230°C min



Heating Time[sec]

0

This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification. For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (http://www.ty-top.com/).

6. Handling ◆Handling 1. Keep the product away from all magnets and magnetic objects. ◆Breakaway PC boards (splitting along perforations) 1. When splitting the PC board after mounting product, care should be taken not to give any stresses of deflection or twisting to the board. 2. Board separation should not be done manually, but by using the appropriate devices. ◆Mechanical considerations Precautions 1. Please do not give the product any excessive mechanical shocks. 2. Please do not add any shock and power to a product in transportation. ◆Pick-up pressure 1. Please do not push to add any pressure to a winding part. Please do not give any shock and push into a ferrite core exposure part. ◆Packing 1. Please avoid accumulation of a packing box as much as possible. 1. There is a case that a characteristic varies with magnetic influence. ◆Breakaway PC boards (splitting along perforations) 1. The position of the product on PCBs shall be carefully considered to minimize the stress caused from splitting of the PCBs. ◆Mechanical considerations Technical 1. There is a case to be damaged by a mechanical shock. considerations 2. There is a case to be broken by the handling in transportation. ◆Pick-up pressure 1. Damage and a characteristic can vary with an excessive shock or stress. **♦**Packing 1. If packing boxes are accumulated, that could cause a deformation on packing tapes or a damage on the products.

7. Storage condi	tions
Precautions	 ♦ Storage 1. To maintain the solderability of terminal electrodes and to keep the packing material in good condition, temperature and humidity in the storage area should be controlled. • Recommended conditions Ambient temperature : 0~40°C Humidity : Below 70% RH • The ambient temperature must be kept below 30°C. Even under ideal storage conditions, solderability of products electrodes may decrease as time passes. For this reason, product should be used within 6 months from the time of delivery. In case of storage over 6 months, solderability shall be checked before actual usage.
Technical considerations	◆Storage 1. Under a high temperature and humidity environment, problems such as reduced solderability caused by oxidation of terminal electrodes and deterioration of taping/packaging materials may take place.

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